

Study of Ultrafast Laser-Induced Acoustics with Plasmonic Gratings

MSc Physics and Astronomy
Master thesis

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Introduction

- Nanolithography machine
- Alignment gratings - buried
- Laser-induced acoustic waves
- Reflect grating shape
- Detect with probe laser

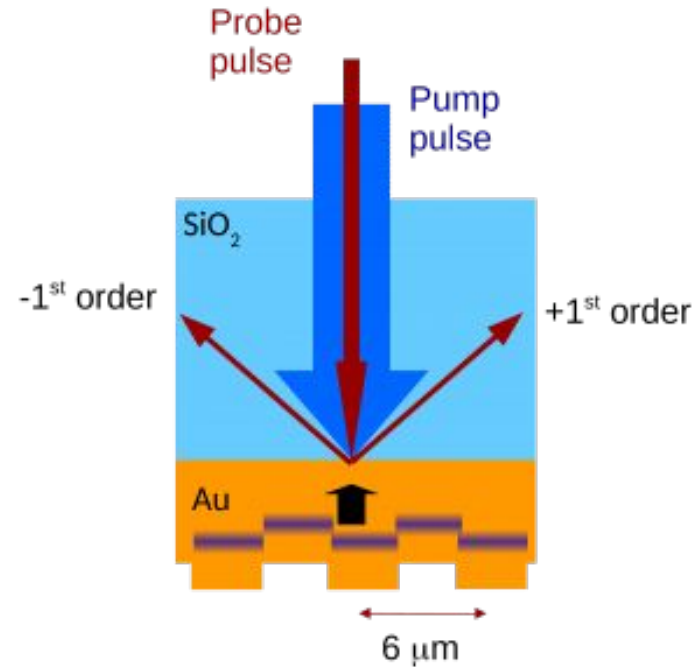


Fig: arcnl.nl/research-groups/light-matter-interaction

Introduction

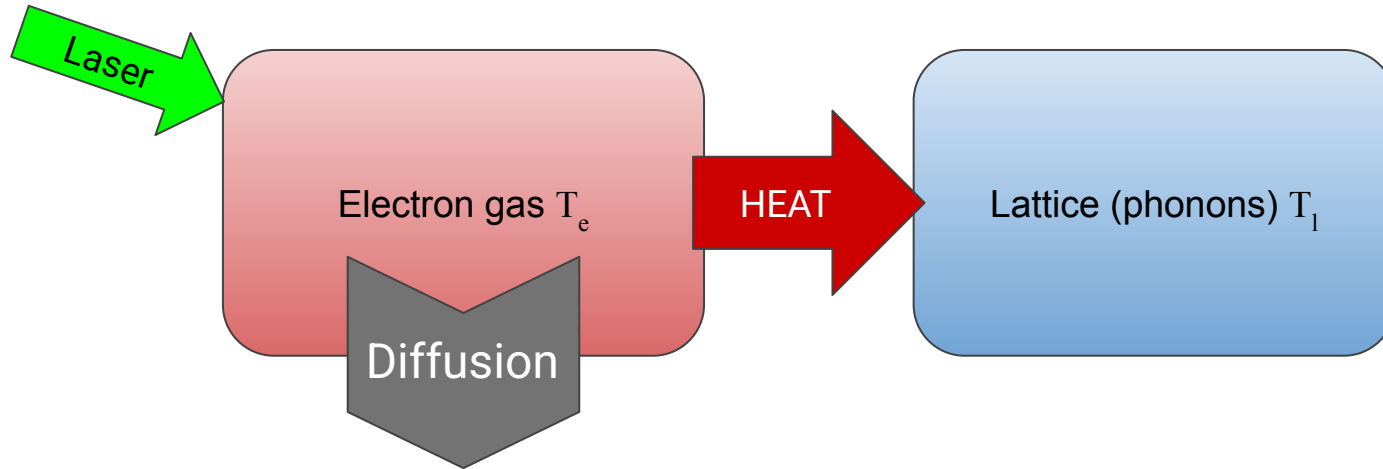
- Challenge: Signal too weak for industrial use
- Enhance with plasmonic resonance

Research:

How does plasmonic resonance enhance signal?

Two-Temperature Model

- Electrons absorb laser
- Heat transfer to the lattice
- Diffuse through electrons
- Determines the time-dependent temperature distribution



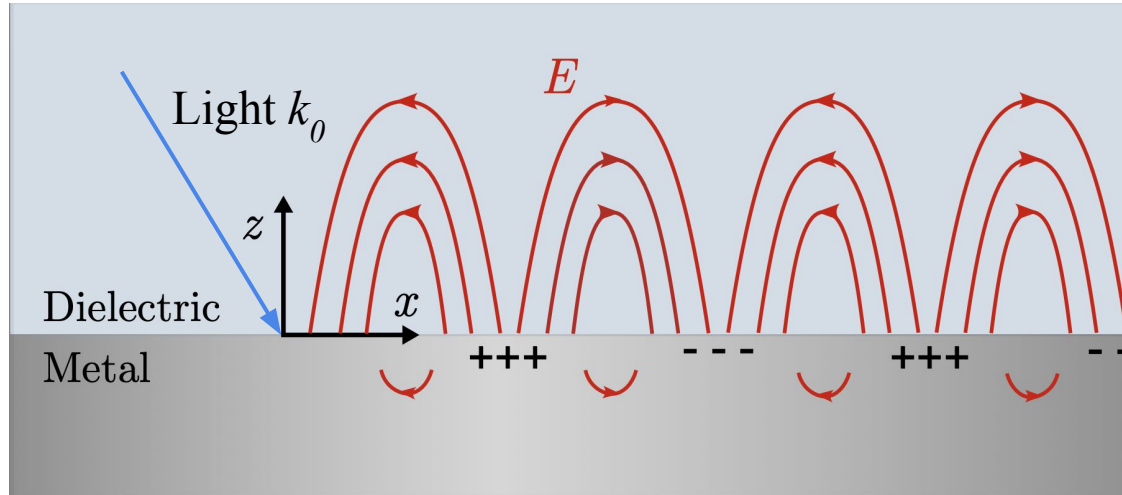
Photoacoustics

What happens after absorption?

- Lattice wants to expand
- Thermal stress
- Propagate into the layer
- Longitudinal wave
- Changes reflectance or diffraction efficiency

Surface Plasmon Polariton (SPP)

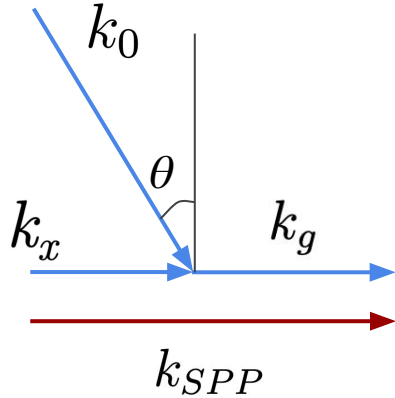
Electromagnetic wave bound to surface of a metal



$$k_{SPP} = \frac{\omega}{c} \sqrt{\frac{\epsilon_m \epsilon_d}{\epsilon_m + \epsilon_d}} > k_0 = \omega/c$$

Impossible in air!

Surface Plasmon Polariton (SPP)



$$|k_x \pm Nk_g| = k_{SPP}$$

↓ ↓

$$\left| \frac{\omega}{c} \sin \theta \pm N \frac{2\pi}{\Lambda} \right| = \frac{\omega}{c} \sqrt{\frac{\epsilon_m \epsilon_d}{\epsilon_m + \epsilon_d}}$$

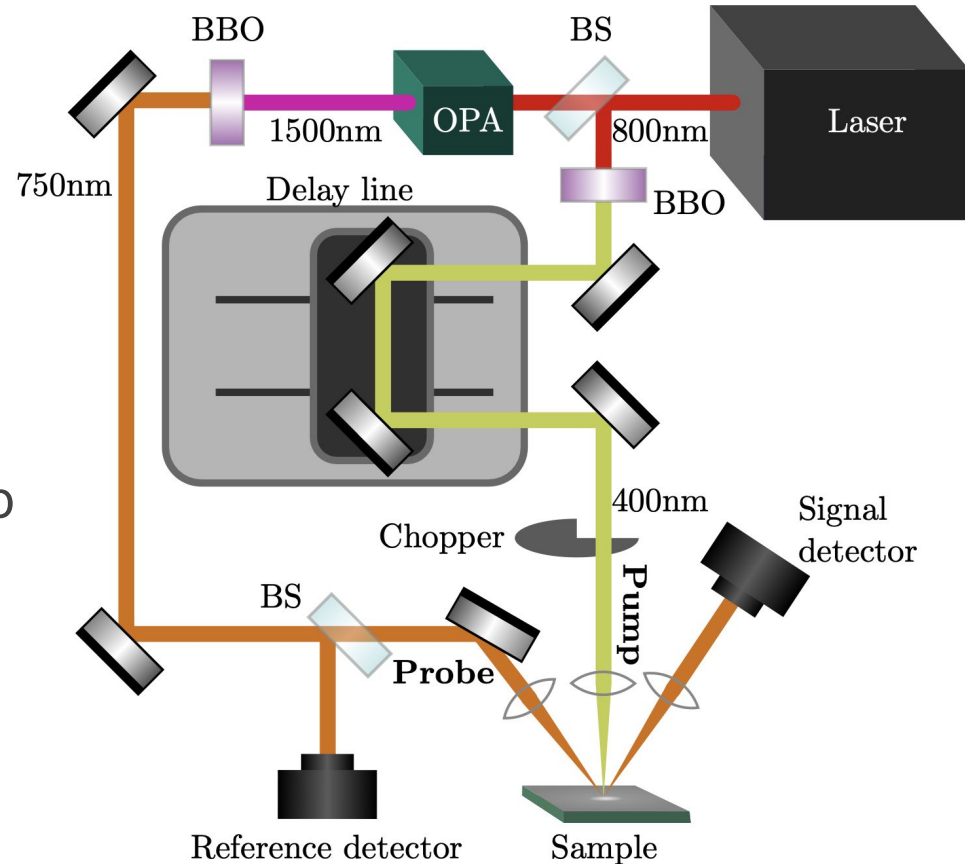
↑

- Grating adds extra k-component
- Absorbs more light when coupled -> minimum reflectance
- Longitudinal wave density oscillation -> change resonance wavelength
- LW induced reflectance change is enhanced near SPP resonance

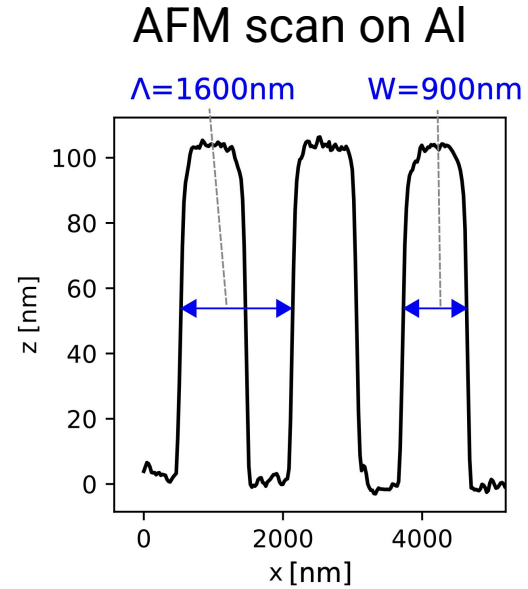
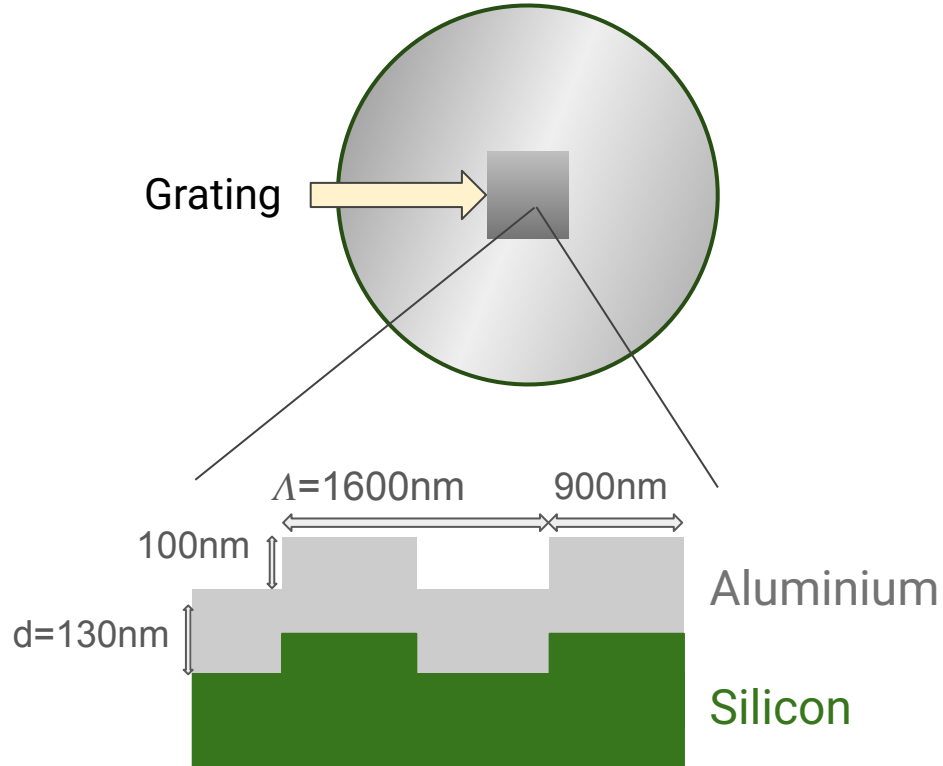
Experiments: Setup

Pump-probe experiments

- 800 nm ultrafast Laser source
 - 35 fs, 1 kHz
- Variable pump-probe delay
- Pump 500 Hz
- Compare with and without pump

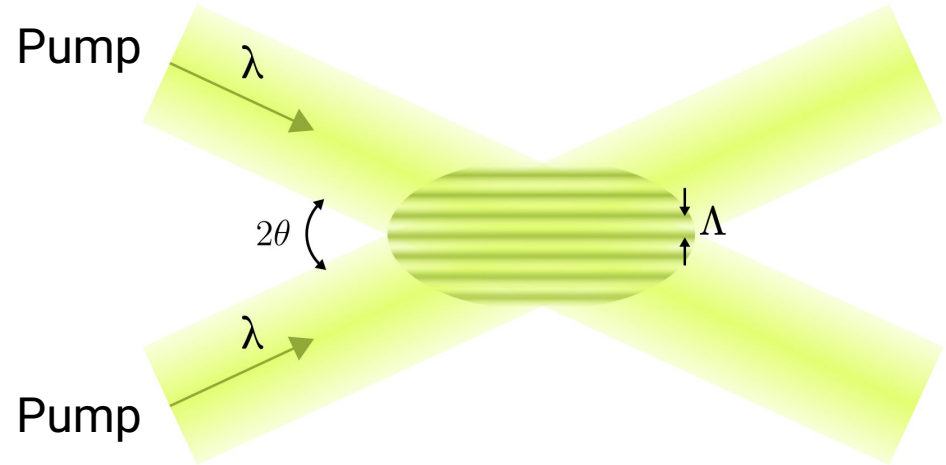


Sample



Experiment 1: Transient grating diffraction change

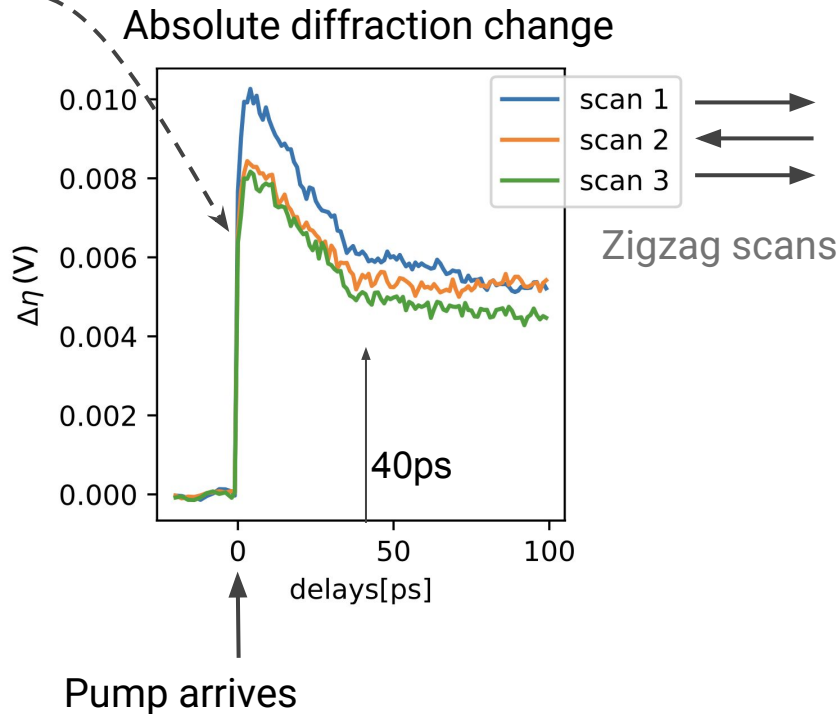
- Split into two 400 nm pump beams
- Cross on flat part of sample
- Interference pattern -> grating
- 750 nm probe pulses
- Diffraction only with pump
- High signal-to-noise



Experiment 1: Transient grating diffraction change

- Rapid absorption by electrons
- Longitudinal wave reflection round trip time: $2d/v_\ell = 40.5$ ps
- Increased diffraction for blocked
- Potential damage

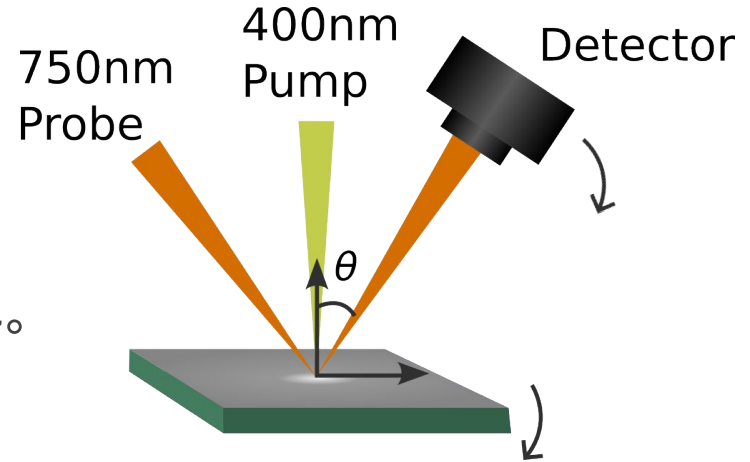
- No clear LW reflection
- Control pump fluence



Experiment 2: Etched grating reflection change

750 nm probe, multiple angles

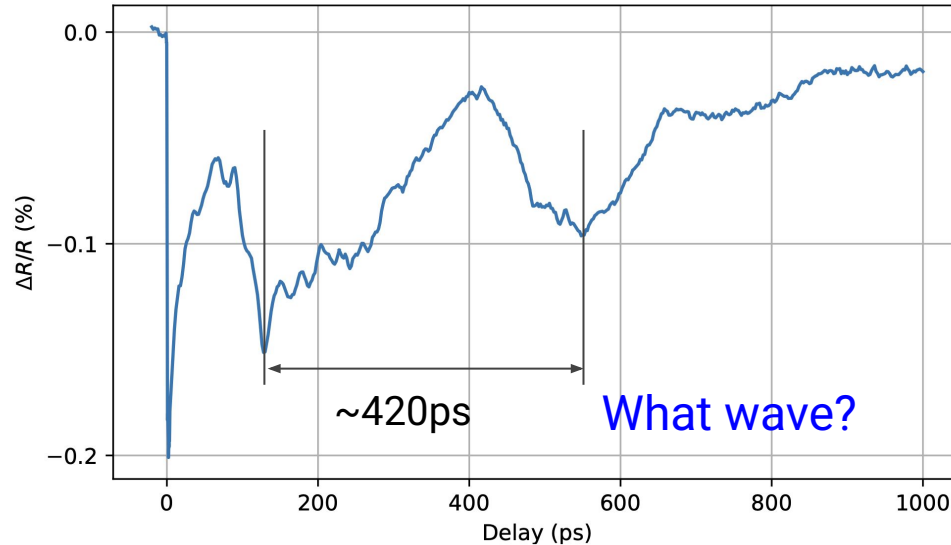
- ONE 400 nm pump beam
- 750 nm probe
- On etched grating
- At and around SPP resonance angle 37°
- Compare SPP resonance with off-resonance



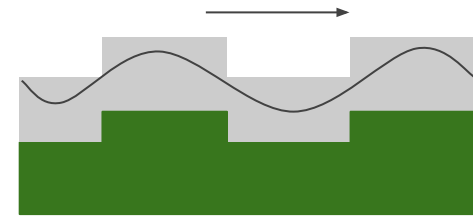
Experiment 2: Etched grating reflection change

750 nm probe, multiple angles

Reflection change at 37°



Surface Acoustic Waves



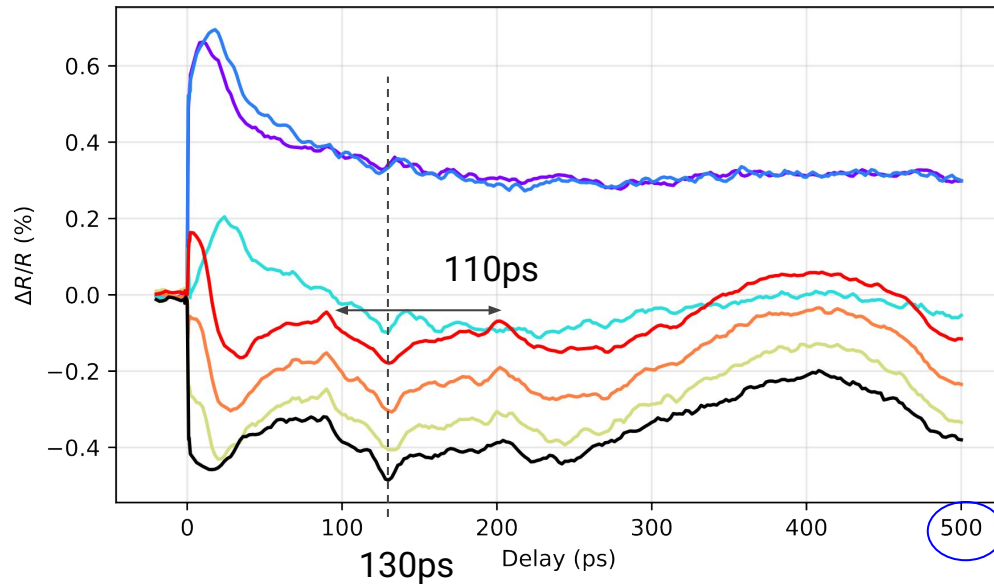
$$T = \frac{\text{grating period}}{\text{transverse speed of sound}}$$
$$= 526\text{ps}$$

Maybe SAW?
No LW (40.5ps)

Experiment 2: Etched grating reflection change

750 nm probe, multiple angles

Reflection change



Larger oscillations at +angles

Changes sign at -angles

- Unknown oscillations
- No longitudinal waves

Experiment 3: Etched grating reflection change

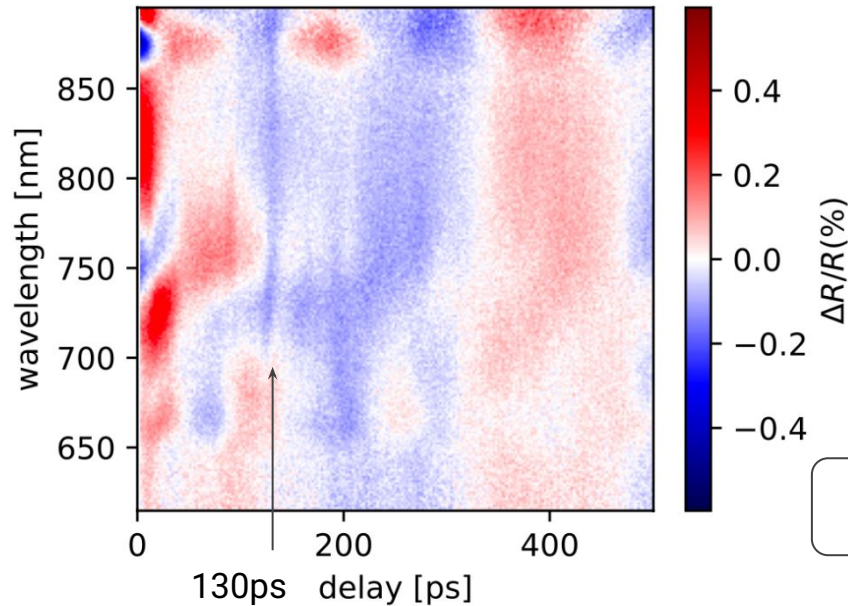
White light probe, fixed angle

- Probe → white light continuum 600~900nm
- Detector → spectrometer
- Incidence at resonance angle for 750 nm $\sim 37^\circ$

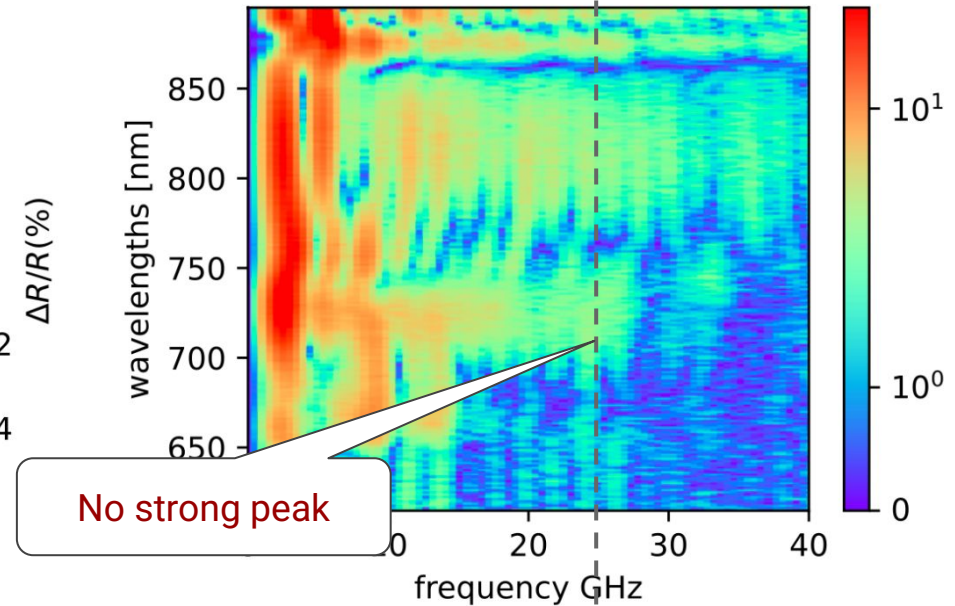
Experiment 3: Etched grating reflection change

White light probe, fixed angle

Reflection change mean removed by row



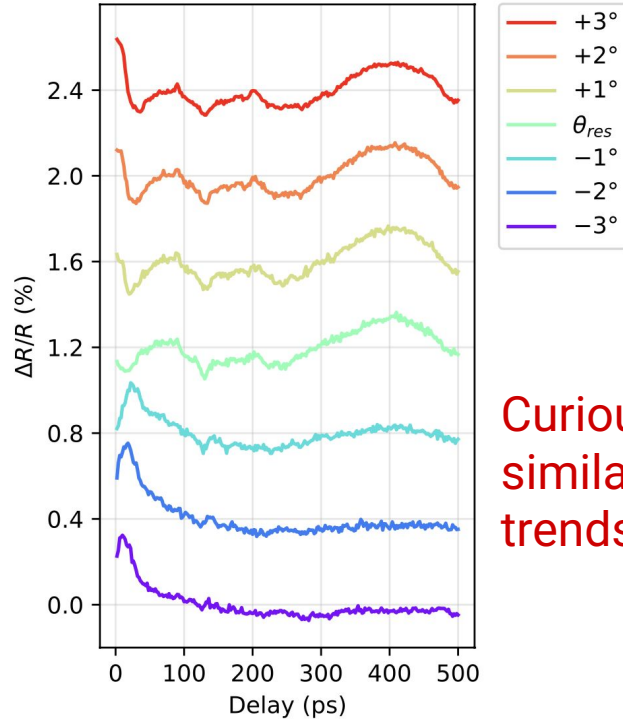
FFT no HP filter



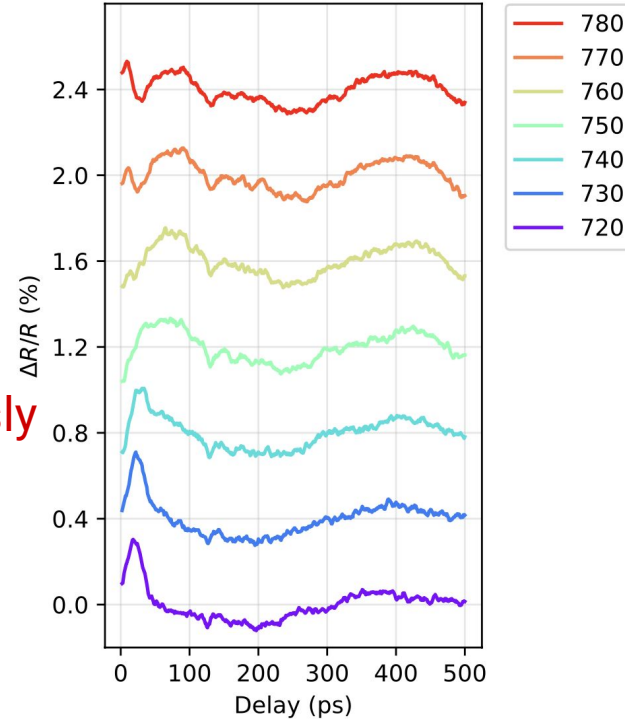
LW: 24.7 GHz

Vary angle of incidence vs Vary probe wavelength

750 nm probe, vary angle



White light probe, 37°



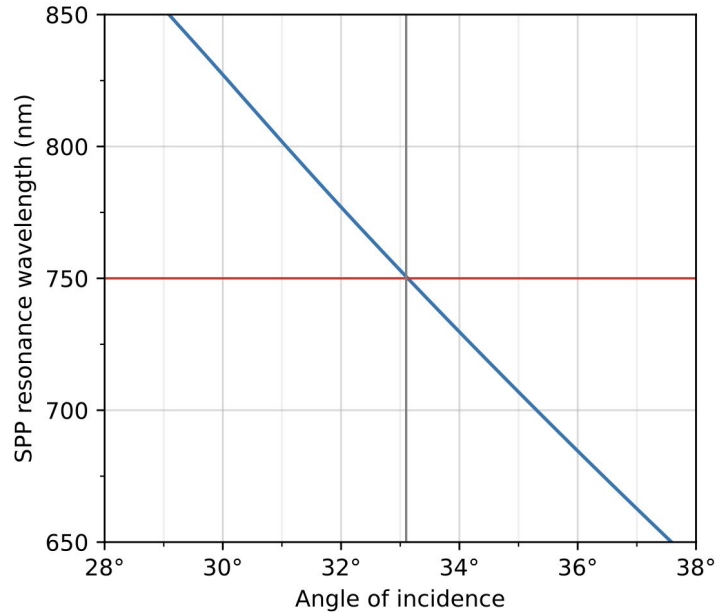
Curiously
similar
trends!

How are angle of incidence and probe wavelength related?

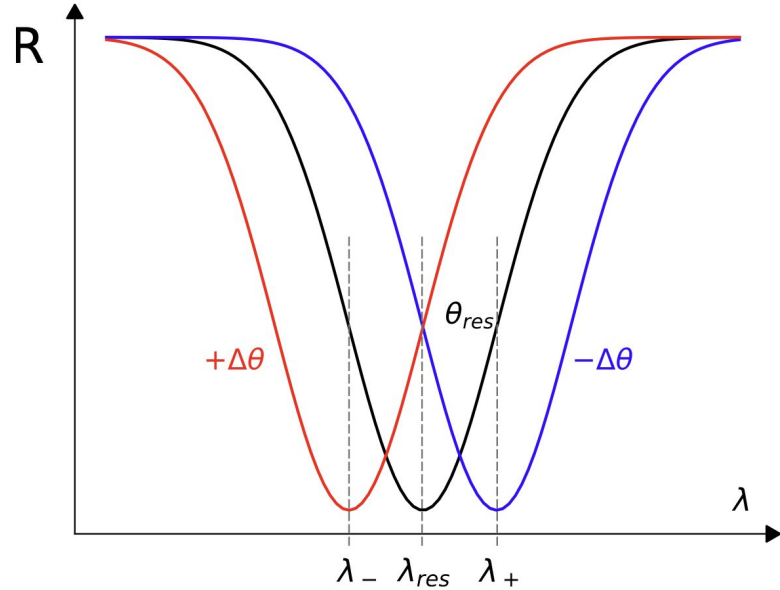
Vary angle of incidence vs Vary probe wavelength

SPP resonance condition

$$\left| \frac{\omega}{c} \sin \theta \pm N \frac{2\pi}{\Lambda} \right| = \frac{\omega}{c} \sqrt{\frac{\epsilon_m \epsilon_d}{\epsilon_m + \epsilon_d}}$$



Angle $\uparrow \Rightarrow$ wavelength \uparrow



No LW: Acoustic Impedance Mismatch

Acoustic impedance: resistance to acoustic waves

$$Z = \rho v$$

Material	Al	Si
Acoustic impedance Z ($10^6 \text{ kg s}^{-1} \text{ m}^{-2}$)	17.4	19.6

Acoustic impedance mismatch small !

Reflection coefficient: fraction of amplitude reflected

$$r = \left| \frac{Z_1 - Z_2}{Z_1 + Z_2} \right| = 6\%$$

Very low LW reflection from substrate !!!

Conclusion

- Complex oscillations
- Unexplained origins
- Angle $\uparrow \Rightarrow$ wavelength \uparrow

Expected enhanced LW signal

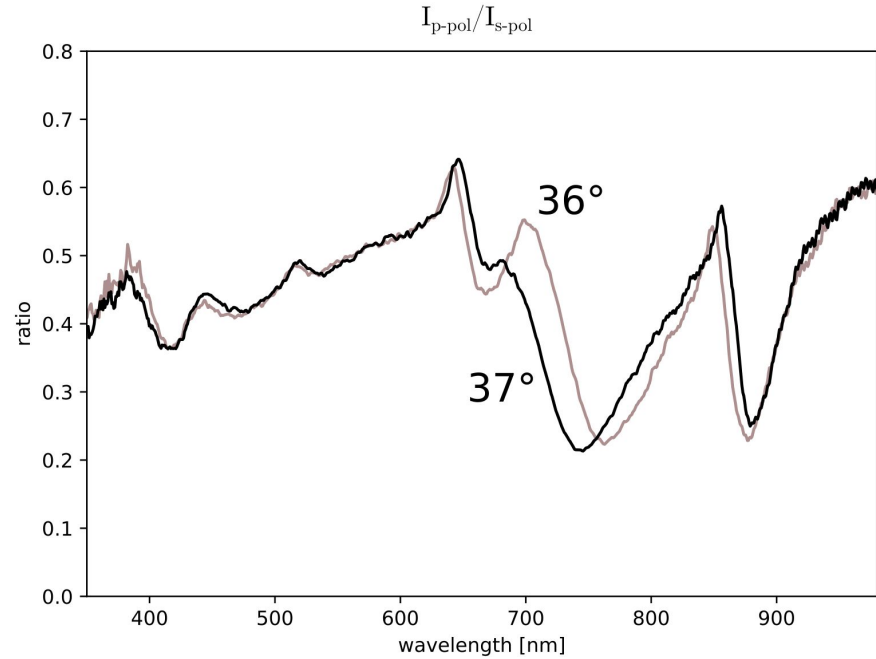
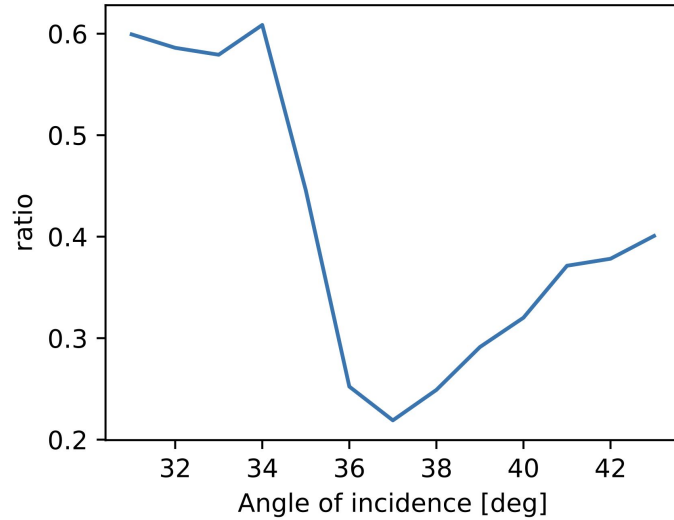
No longitudinal waves reflections!

Main reason:

**Acoustic impedance mismatch
too small for Al/Si**

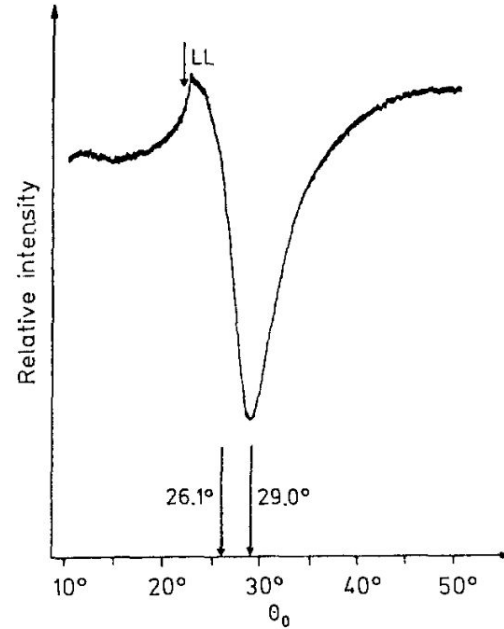
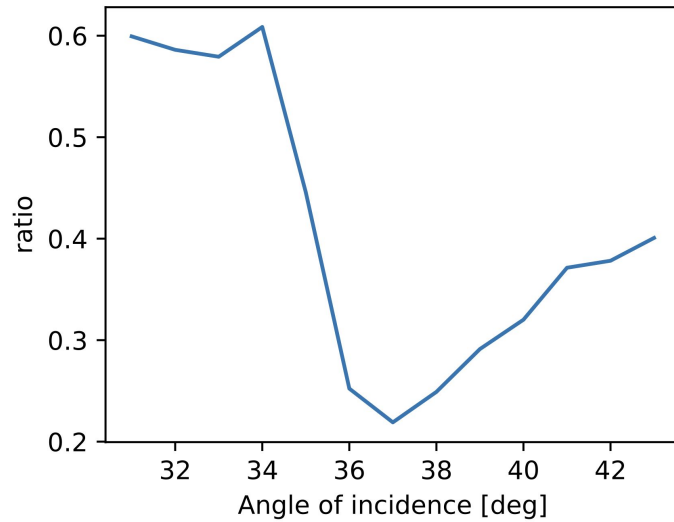
Supplementary

Reflectance for 750nm on grating

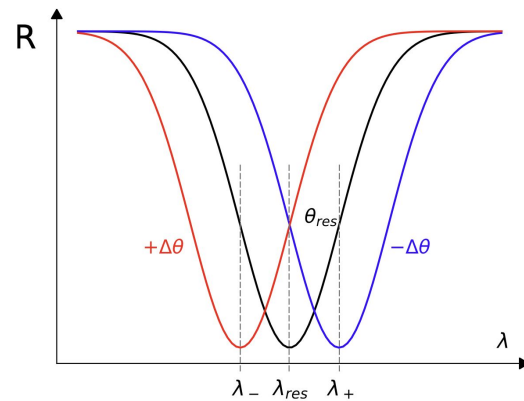
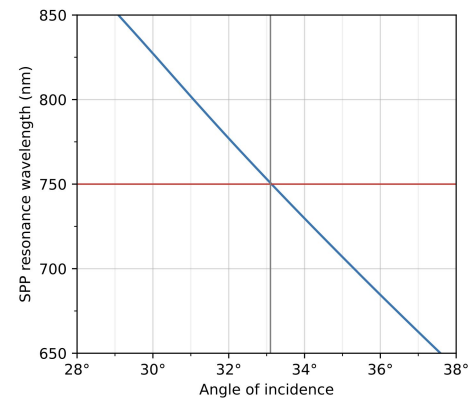
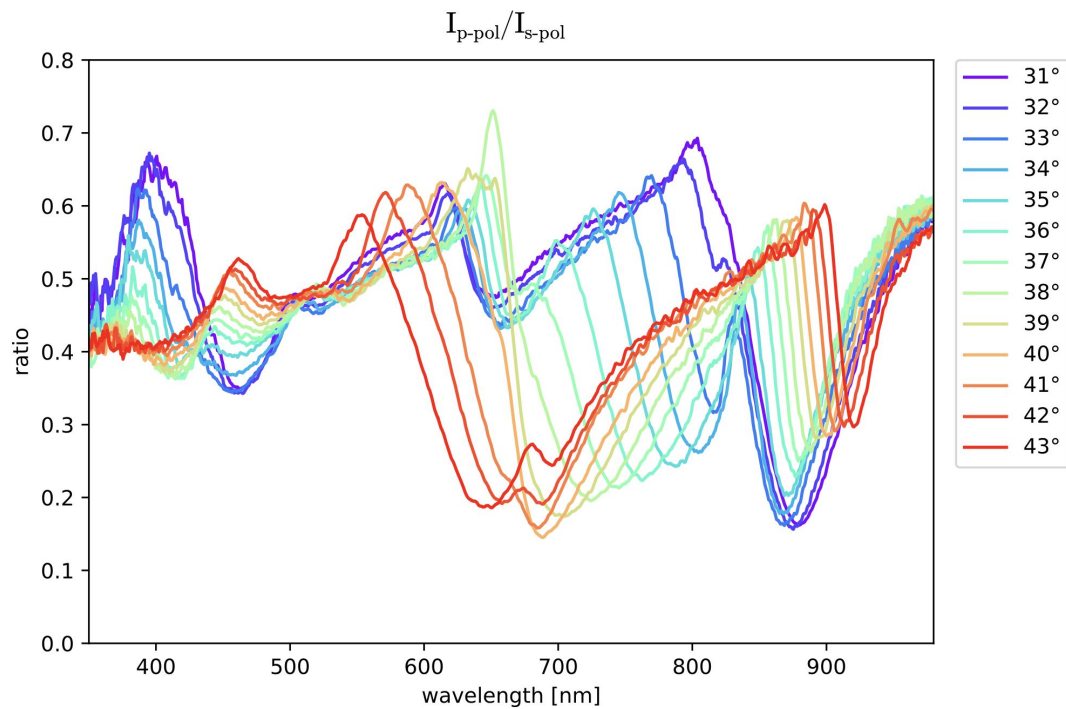


Supplementary

Reflectance for 750nm on grating

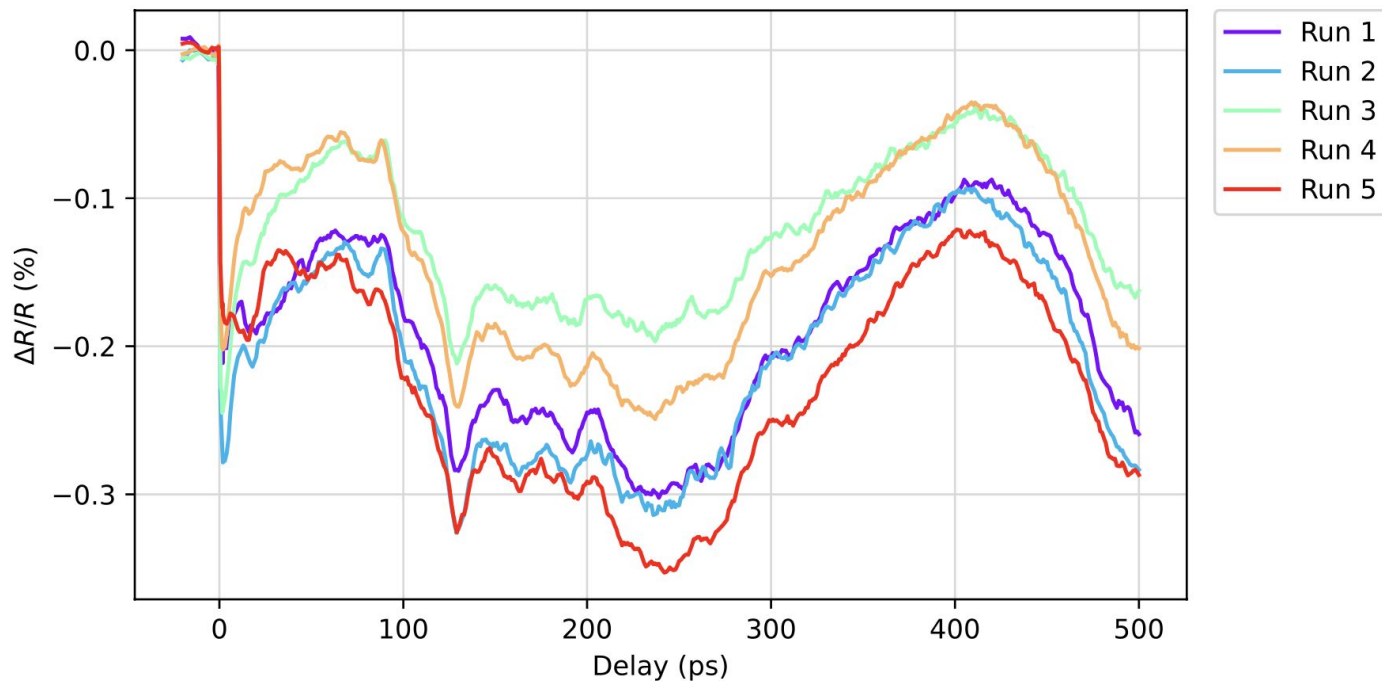


Supplementary



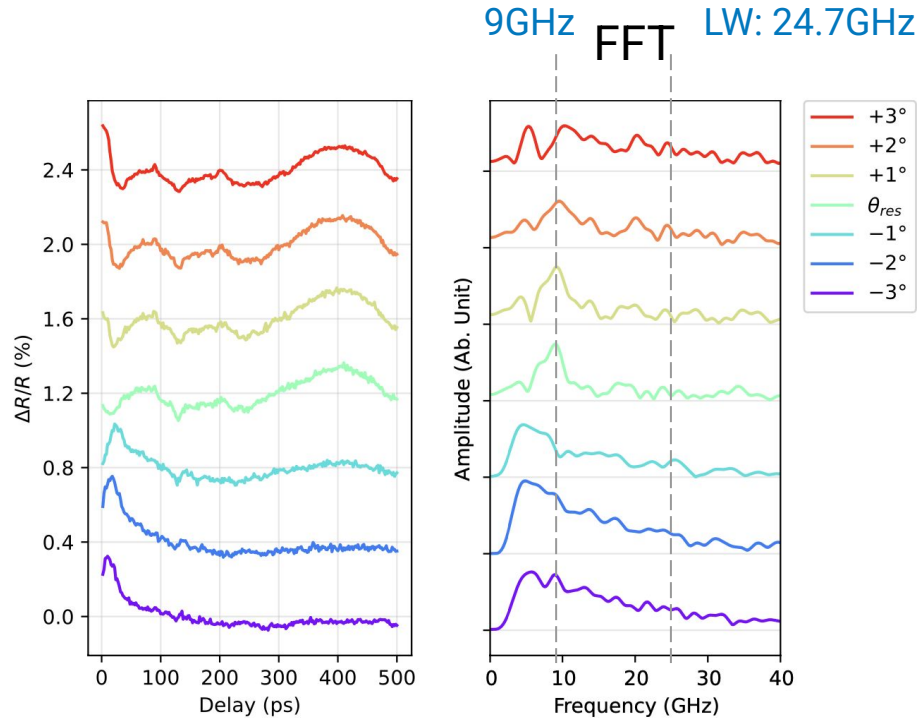
Supplementary

Reflection change 750nm probe at resonance



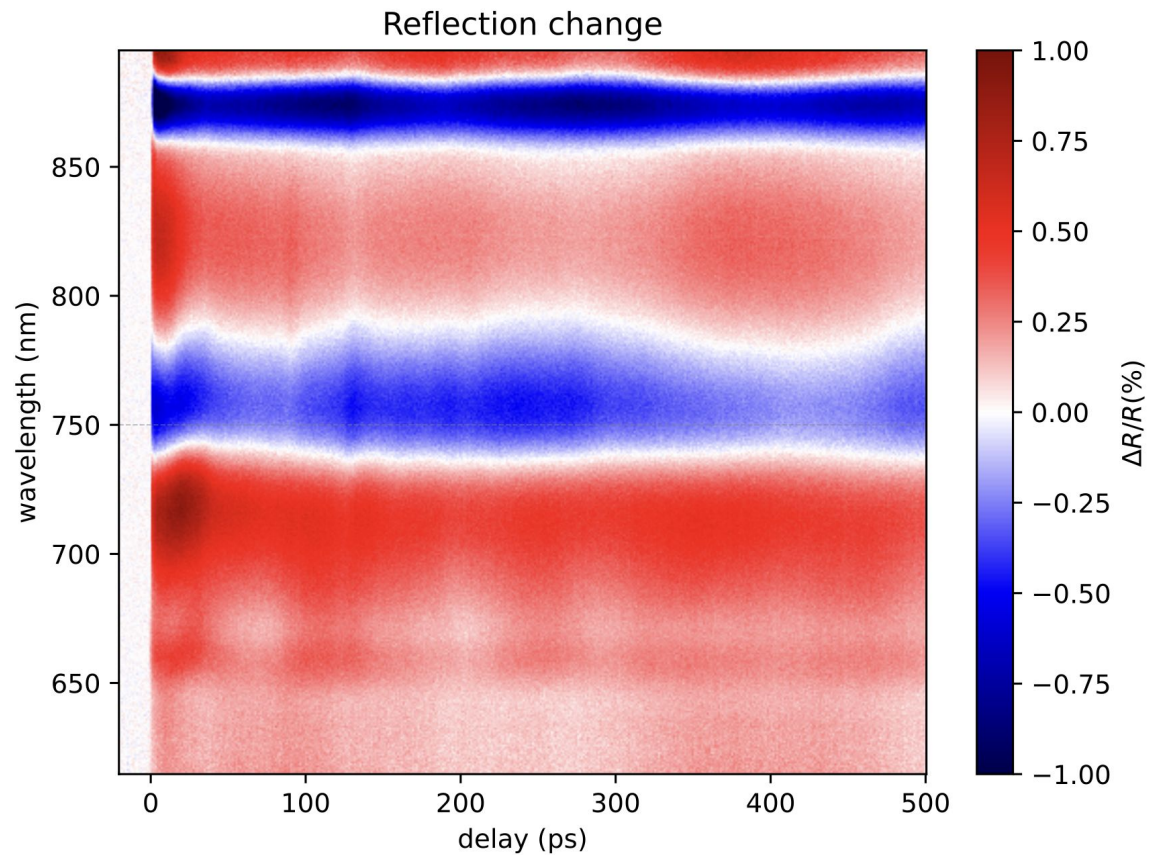
Experiment 2: Etched grating reflection change

750 nm probe, multiple angles



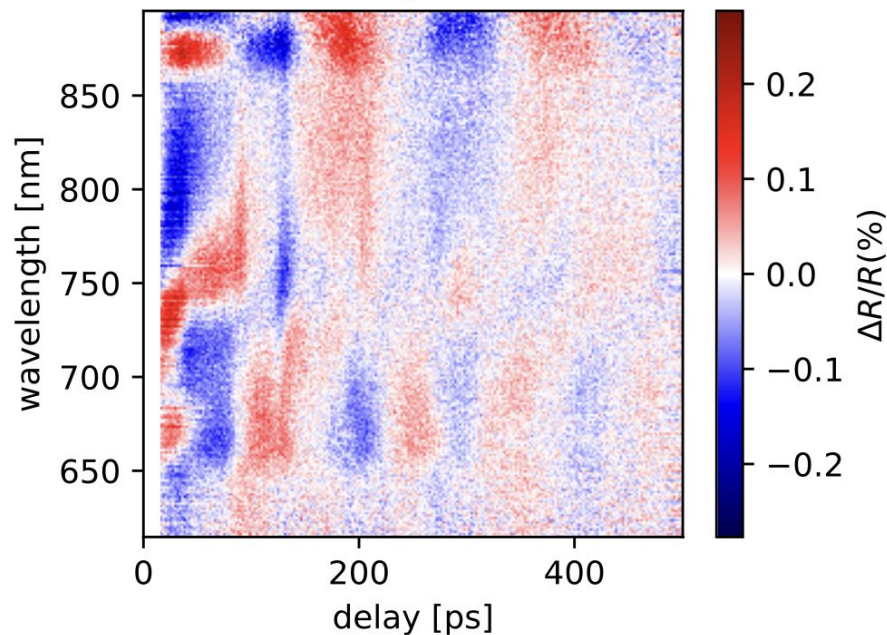
$$\text{LW: } f = 1/40.5 \text{ ps} = 24.7 \text{ GHz}$$

Supplementary

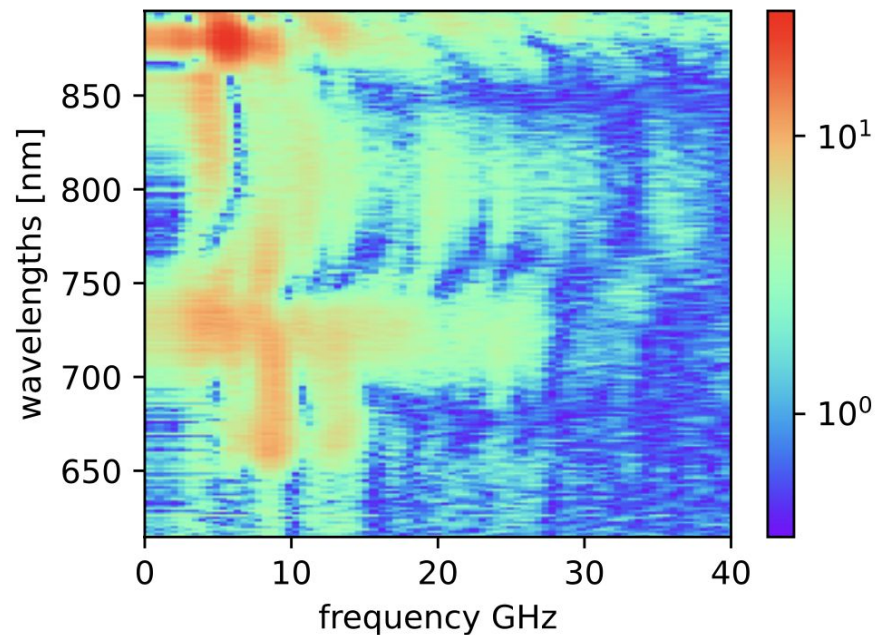


Supplementary

Reflection change 4GHz HP filter



FFT 4GHz HP filter



Supplementary

Material	Al	Si	SiO ₂
Density ρ (kg m ⁻³)	2710	2330	2650
Speed of sound v (m s ⁻¹)	6420	8430	5780
Acoustic impedance Z (10 ⁶ kg s ⁻¹ m ⁻²)	17.4	19.6	15.4
Reflection coefficient r with Al	0%	5.95%	6.10%

Supplementary

